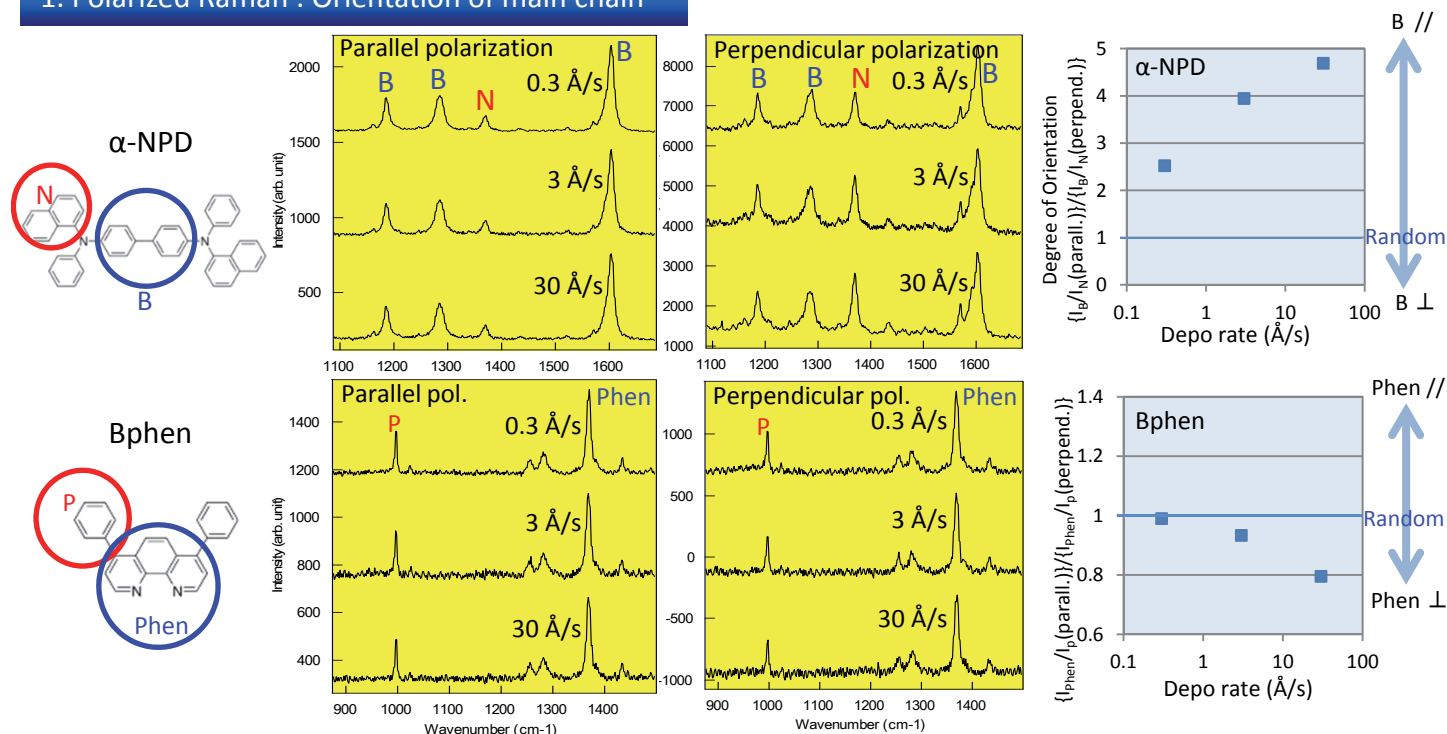


Molecular orientation analysis in organic thin films for OLED

Raman and Angle resolved XAFS reveal molecular orientation in organic thin films. Using two modes of XAFS measurement, you can compare top surface vs. bulk of those films.

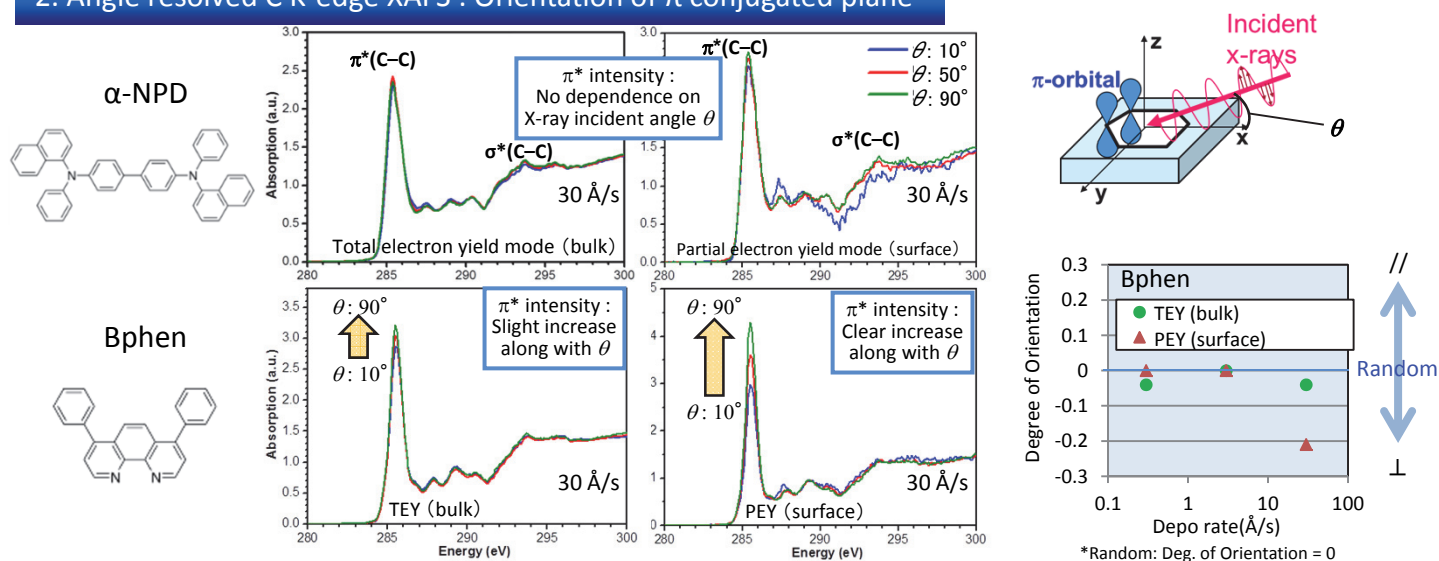
Samples: Organic films (α -NPD or Bphen, 200 nm) / ITO / Glass-sub. (Deposition rates : 0.3, 3, 30 Å/s)

1. Polarized Raman : Orientation of main chain



α -NPD : Parallel orientation of biphenyl group to substrate
 Bphen : Weak perpendicular orientation of phenanthroline group
 Dep. Rate dependence : Increase in orientation along with deposition rate
 * Degree of orientation = Ratio of normalized intensities of main chain band in parallel vs. perpendicular configuration

2. Angle resolved C K-edge XAFS : Orientation of π conjugated plane



α -NPD : Random both in bulk and at surface at all deposition rates
 Bphen : Top surface of the film of deposition rate of 30 Å/s shows clear orientation perpendicular to the substrate.